

**Search Notes**

Application/Control No.

09/852,326

Examiner

Sheela C. Chawan

Applicant(s)/Patent under  
Reexamination

TAKADA ET AL.

Art Unit

2625

**SEARCHED**

Class	Subclass	Date	Examiner
382	152,199, 203	7/1/2005	SCC
702	167	7/1/2005	SCC
356	495	7/1/2005	SCC
ABOVE	SEARCH	7/1/2005	SCC
UP-DATE			

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
382	152,199	7/1/2005	SCC
382	203	7/1/2005	SCC
702	167	7/1/2005	SCC
356	495	7/1/05	SCC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST, US-PGPUB, USPAT,EPO,JPO,DERWENT,IBM- TDB, see search history printout. and update the search.	7/1/2005	SCC
382/152,199,203 . 702/167. 356/495. US- Patent Only, see text search.	7/1/2005	SCC
Interference Seach , See Search History Print Out.	7/1/2005	SCC
Inventer Name Search.	7/1/2005	SCC
IEEE, SEARCH .	7/1/2005	SCC